Search Notes

Application/Control No.	lo. Applicant(s)/Patent under Reexamination	
10/517,360	NAKANO ET AL.	
Examiner	Art Unit	
Phuongchi Nguyen	2833	

					
SEARCHED					
Class	Subclass	Date	Examiner		
439	417	2/27/2006	С		
439	499	2/27/2006	С		
439	404	2/27/2006	ç		
439	405	2/27/2006	С		
updated	search	10/2/2006	С		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
see text search attached		10/2/2006	С	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
see text search attched	10/2/2006	С		
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